

<b>Notice of References Cited</b>	Application/Control No. 10/706,777	Applicant(s)/Patent Under Reexamination RISTIC-LEHMANN ET AL.	
	Examiner Henry S. Hu	Art Unit 1713	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,068,882	05-2000	Ryu, Jaesook	427/246
	C	US-			
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	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO-2005/047381 A1	05-2005	WO	Ristic-Lehmann et al.	----
*	O	EP-552,484 A	07-1993	EP	Mielke et al. <i>(only abstract)</i>	----
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	Q	EP-672,635 A	03-1995	EP	Mielke et al.	<i>WLB</i> ----
	R	WO-9832709 A	07-1998	WO	Schwertfeger et al.	----
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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*[Signature]* 2-2-06